# onsemi

#### DATA SHEET www.onsemi.com

# **IGBT** - Field Stop, Trench, Soft Fast Recovery Diode 650 V, 160 A FGY160T65SPD-F085

#### Benefits

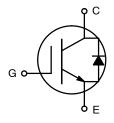
- Very Low Conduction and Switching Losses for a High Efficiency Operation in Various Applications
- Rugged Transient Reliability
- Outstanding Parallel Operation Performance with Balance Current Sharing
- Low EMI

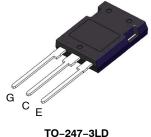
#### Features

- AEC-Q101 Qualified and PPAP Capable
- Very Low Saturation Voltage: V<sub>CE(sat)</sub> = 1.6 V (Typ.) @ I<sub>C</sub> = 160 A
- Maximum Junction Temperature:  $T_J = 175^{\circ}C$
- Positive Temperature Co-Efficient
- Tight Parameter Distribution
- High Input Impedance
- 100% of the Parts are Dynamically Tested
- Short circuit ruggedness > 6 µs @ 25°C
- Copacked with Soft, Fast Recovery Extremefast Diode
- This Device is Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### Applications

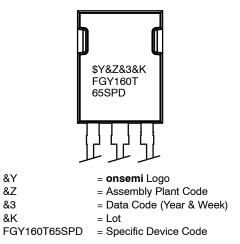
- Traction Inverter for HEV/EV
- Auxiliary DC/AC Converter
- Motor Drives
- Other Power-Train Applications Requiring High Power Switch





CASE 340CU

#### MARKING DIAGRAM



#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

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#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Ratings	Unit
V <sub>CES</sub>	Collector to Emitter Voltage	650	V
V <sub>GES</sub>	Gate to Emitter Voltage	±20	V
	Transient Gate to Emitter Voltage	±30	V
Ι <sub>C</sub>	Collector Current @ T <sub>C</sub> = 25°C (Note 1)	240	А
	Collector Current @ T <sub>C</sub> = 100°C	220	А
I <sub>Nominal</sub>	Nominal Current	160	А
I <sub>CM</sub>	Pulsed Collector Current	480	А
I <sub>FM</sub>	Diode Forward Current @ $T_C = 25^{\circ}C$ (Note 1)	240	А
	Diode Forward Current @ T <sub>C</sub> = 100°C	188	А
PD	Maximum Power Dissipation @ $T_C = 25^{\circ}C$	882	W
	Maximum Power Dissipation @ $T_C = 100^{\circ}C$	441	W
SCWT	Short Circuit Withstand Time @ $T_C = 25^{\circ}C$	6	μs
$\Delta V / \Delta t$	Voltage Transient Ruggedness (Note 2)	10	V/ns
TJ	Operating Junction Temperature	–55 to +175	°C
T <sub>stg</sub>	Storage Temperature Range	–55 to +175	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Limited to bondwire. 2. V<sub>CC</sub> = 400 V, V<sub>GE</sub> = 15 V, I<sub>CE</sub> = 480 A, Inductive load.

#### **THERMAL CHARACTERISTICS**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case	-	0.17	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	-	0.32	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	40	°C/W

#### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Packing Type	Qty per Tube
FGY160T65SPD	FGY160T65SPD-F085	TP-247-3LD	Tube	30 ea

#### ELECTRICAL CHARACTERISTICS OF THE IGBT (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
OFF CHARAC	TERISTICS					
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$V_{GE}$ = 0 V, $I_C$ = 1 mA	650	-	-	V
$\Delta BV_{CES}/\Delta T_{J}$	Temperature Coefficient of Breakdown Voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 1 mA	_	0.6	-	V/°C
I <sub>CES</sub>	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$	-	-	40	μΑ
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	±250	nA

#### **ON CHARACTERISTICS**

V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_{C}$ = 160 mA, $V_{CE}$ = $V_{GE}$	4.3	5.3	6.3	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	$I_{C}$ = 160 A, $V_{GE}$ = 15 V	-	1.6	2.05	V
		I <sub>C</sub> = 160 A, V <sub>GE</sub> = 15 V, T <sub>J</sub> = 175°C	-	2.15	-	V

#### ELECTRICAL CHARACTERISTICS OF THE IGBT (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
DYNAMIC CH	IARACTERISTICS				•	
Cies	Input Capacitance	$V_{CE} = 30 V, V_{GE} = 0 V,$	_	6710	-	pF
C <sub>oes</sub>	Output Capacitance	f = 1  MHz	_	450	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance		_	55	-	pF
R <sub>G</sub>	Internal Gate Resistance	f = 1 MHz	_	3	-	Ω
SWITCHING (	CHARACTERISTICS					
T <sub>d(on)</sub>	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 160 \text{ A}, \\ R_{G} = 5 \Omega, \text{ V}_{GE} = 15 \text{ V}, \\ \text{Inductive Load, } \text{ T}_{\text{J}} = 25^{\circ}\text{C}$	_	53	-	ns
Tr	Rise Time		_	197	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time		-	98	-	ns
Т <sub>f</sub>	Fall Time		-	141	-	ns
Eon	Turn-On Switching Loss		-	12.4	-	mJ
E <sub>off</sub>	Turn-Off Switching Loss		-	5.7	-	mJ
E <sub>ts</sub>	Total Switching Loss		-	18.1	-	mJ
T <sub>d(on)</sub>	Turn-On Delay Time	$V_{CC} = 400 \text{ V}, \text{ I}_{C} = 160 \text{ A},$	-	52	-	ns
Tr	Rise Time	$R_G = 5 \Omega$ , $V_{GE} = 15 V$ , Inductive Load, $T_J = 175^{\circ}C$	-	236	-	ns
T <sub>d(off)</sub>	Turn-Off Delay Time		-	104	-	ns
Т <sub>f</sub>	Fall Time		-	204	-	ns
Eon	Turn-On Switching Loss		-	21	-	mJ
E <sub>off</sub>	Turn-Off Switching Loss		-	8.5	-	mJ
E <sub>ts</sub>	Total Switching Loss		_	29.5	-	mJ
Qg	Total Gate Charge	$V_{CE} = 400 \text{ V}, I_{C} = 160 \text{ A},$	_	163	245	nC
Q <sub>ao</sub>	Gate to Emitter Charge	V <sub>GE</sub> = 15 V	_	50	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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nC

nC

#### **ELECTRICAL CHARACTERISTICS OF THE DIODE** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Gate to Emitter Charge

Gate to Collector Charge

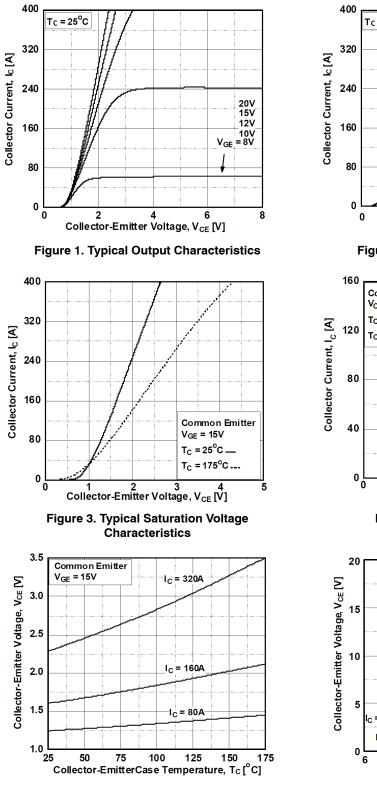
Qge

Q<sub>gc</sub>

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V <sub>FM</sub>	Diode Forward Voltage	I <sub>F</sub> = 160 A	$T_J = 25^{\circ}C$	-	1.4	1.7	V
			T <sub>J</sub> = 175°C	-	1.35	-	
E <sub>rec</sub>	Reverse Recovery Energy	$V_{CE} = 400 \text{ V}, I_F = 160 \text{ A},$	$T_J = 25^{\circ}C$	-	598	-	μJ
	$\Delta I_{F}/\Delta t = 1000 \text{ A}/\mu \text{s}$ $T_{J} = 175^{\circ}\text{C}$	T <sub>J</sub> = 175°C	-	4000	-		
T <sub>rr</sub>	Diode Reverse Recovery		$T_J = 25^{\circ}C$	-	132	-	ns
	Time		T <sub>J</sub> = 175°C	-	245	-	
Q <sub>rr</sub>	Diode Reverse Recovery	1	$T_J = 25^{\circ}C$	-	3.3	-	μC
	Charge		T <sub>J</sub> = 175°C	-	12.5	-	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### **TYPICAL PERFORMANCE CHARACTERISTICS**





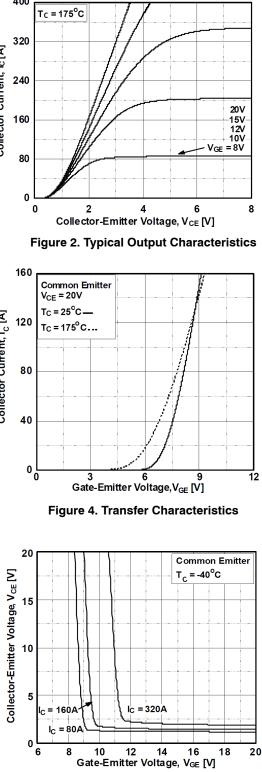
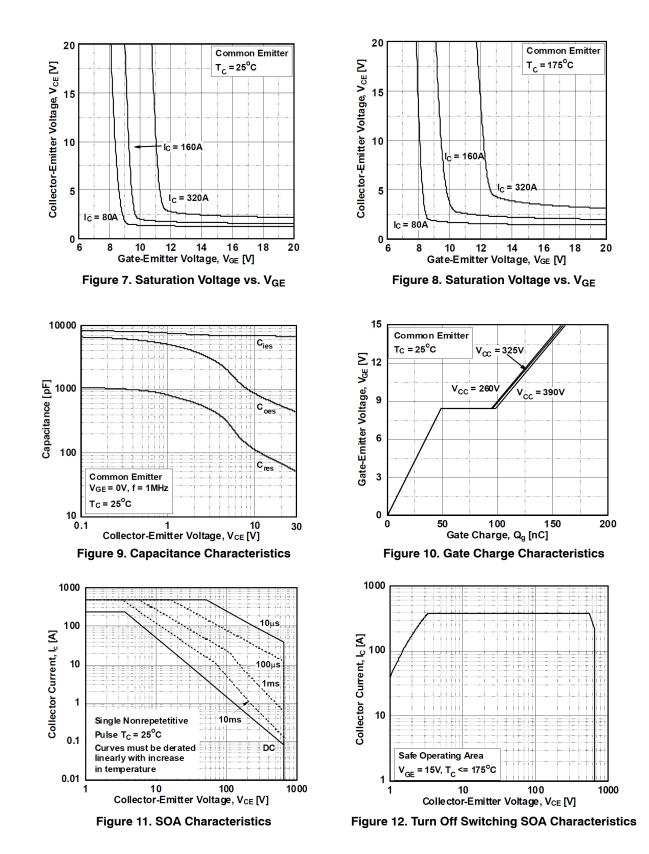


Figure 6. Saturation Voltage vs. V<sub>GE</sub>



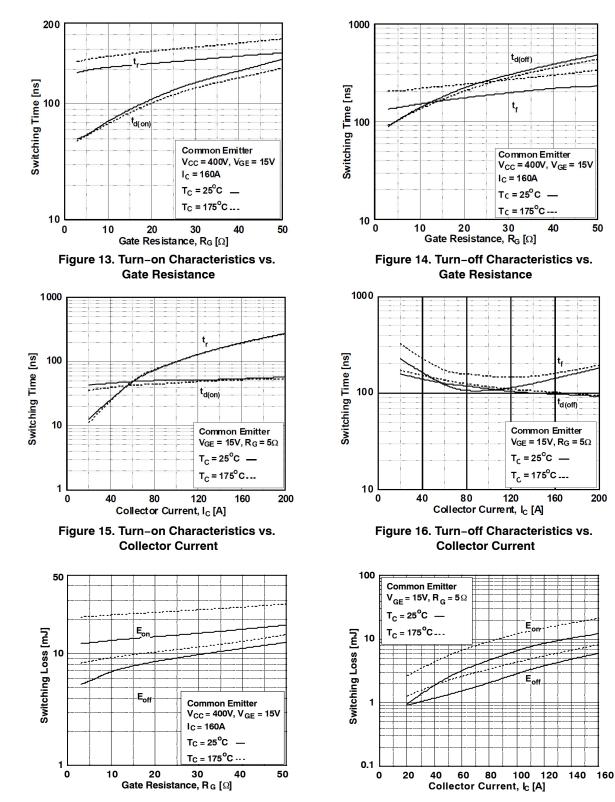
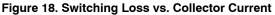
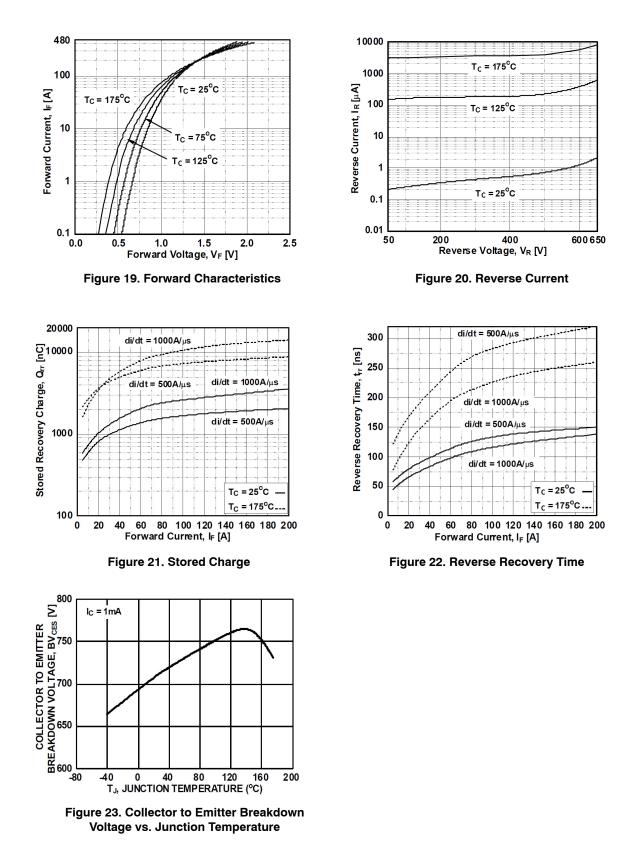


Figure 17. Switching Loss vs. Gate Resistance





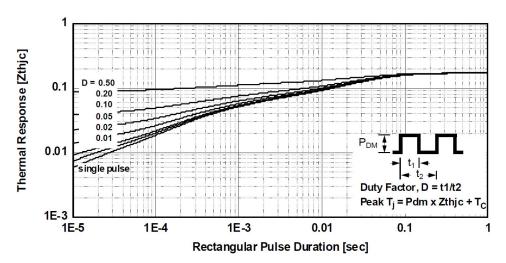


Figure 24. Transient Thermal Impedance of IGBT

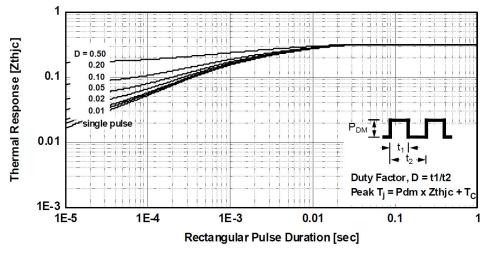
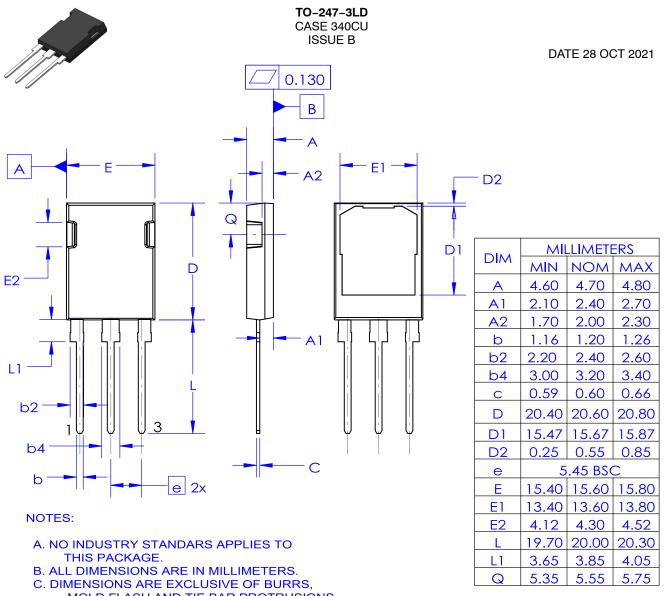


Figure 25. Transient Thermal Impedance of Diode





MOLD FLASH AND TIE BAR PROTRUSIONS. D. DRAWING CONFORMS TO ASME Y14.5-2009.

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#### GENERIC **MARKING DIAGRAM\***



- XXXX = Specific Device Code = Assembly Site Code = Year WW = Work Week
  - = Assembly Lot Code
- \*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

DESCRIPTION: TO-247-3LD PAGE 1 OF	DOCUMENT NUMBER:	98AON13773G	Electronic versions are uncontrolled except when accessed directly from Printed versions are uncontrolled except when stamped "CONTROLLED	
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